

Integrated Device Technology, Inc. 6024 Silver Creek Valley Road, San Jose, CA - 95138

PRODUCT/PROCESS CHANGE NOTICE (PCN)

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PCN #:	N1009-01	DATE: November 19, 2010	MEANS OF DISTINGUISHING CHANGED DEVICES:					
Product Affected:			Product Mark					
	843312AKLF, 843312	AKLFT	Back Mark					
	843312AKILF, 843312	AKILFT	Date Code					
Date Effe	ctive: February 19, 2	2011	Other Ship Date					
Contact:	Rodney Corpuz							
Title:	Product Quality Assura	nce	Attachment: Yes No					
Phone #:	(408) 284-8261							
Fax #:	(408) 284-1450		Samples: Available now					
E-mail:	rcorpuz@idt.com							
DESCRI	PTION AND PURPOSE	E OF CHANGE:						
Die Te	echnology							
□ Wafer	Fabrication Process	This notification is to adv	vise our customers that IDT has updated the datasheet and					
	bly Process		I3312AKLF and 843312AKILF.					
Equip								
□ Materi■ Testin								
	g facturing Site							
Data S								
□ Other								
RELIAB	ILITY/QUALIFICATI	ON SUMMARY:						
There is no expected change to the product quality or reliability performance.								
CUSTOMER ACKNOWLEDGMENT OF RECEIPT: IDT records indicate that you require written notification of this change. Please use the acknowledgement below or E-Mail to grant approval or request additional information. If IDT does not receive acknowledgement within 90 days of this notice it will be assumed that this change is acceptable. IDT reserves the right to ship either version manufactured after the process change effective date until the inventory on the earlier version has been depleted.								
Custome	r:	□	Approval for shipments prior to effective date.					
Name/Da	ate:	E-	Mail Address:					
Title:		Ph	one# /Fax# :					
CUSTOMER COMMENTS:								
IDT ACKNOWLEDGMENT OF RECEIPT:								
	V.		DATE.					
RECD. B	1.		DATE:					



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ATTACHMENT I - PCN # : N1009-01

PCN Type:Product LineData Sheet Change:YesDetails Of Change:

The following datasheet parameters will be updated on the datasheet and test program to reflect the changes.

From:

Table 6A. AC Characteristics, $V_{CC} = V_{CCO} = 3.3V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40^{\circ}C$ to $85^{\circ}C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
odc	Output Duty Cycle		45		55	%

To:

Table 6A. AC Characteristics, $V_{CC} = V_{CCO} = 3.3V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40^{\circ}C$ to $85^{\circ}C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
odc	Output Duty Cycle	f _{OUT} = 125	45		55	%
		f _{OUT} = 312.5	40		60	%

Affected Devices: 843312AKLF, 843312AKLFT, 843312AKILFT

Sample Availability:

Samples are now available for all affected devices.

Please contact your local IDT sales representative for your sample request.